

4/19/2004

SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

252069US2

SERIAL NO.

New Application

10/834391

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Hideki TAKAHASHI, et al.

FILING DATE

Herewith

GROUP

2815

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,086,324	02/04/92	Hiroyasu HAGINO			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
ML	AO	7-153942	06/16/95	Japan (with English abstract and computer generated English translation)		
ML	AP	6-53511	02/25/94	Japan (with English abstract and computer generated English translation)		
ML	AQ	2-126682	05/15/90	Japan (Corresponding to U.S. Pat. 5,086,324)		X
ML	AR	6-196705	07/15/94	Japan (with English abstract and computer generated English translation)		
ML	AS	8-116056	05/07/96	Japan (with English abstract and computer generated English translation)		
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Muth C. John

Date Considered

7/26/05

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449
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10/826,391

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APPLICANT

Hideki TAKAHASHI, et al.

FILING DATE

April 19, 2004

GROUP

2811

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>me</i>	AA	6,107,650	08/22/00	TAKAHASHI et al.			
<i>me</i>	AB	5,864,159	01/26/99	TAKAHASHI			
<i>me</i>	AC	5,751,024	05/12/98	TAKAHASHI			
<i>me</i>	AD	5,801,408	09/01/98	TAKAHASHI			
<i>me</i>	AE	5,981,981	11/09/99	TAKAHASHI			
<i>me</i>	AF	6,118,150	09/12/00	TAKAHASHI			
<i>me</i>	AG	6,040,599	03/21/00	TAKAHASHI			
<i>me</i>	AH	6,198,130	03/06/01	NOBUTO et al.			
<i>me</i>	AI	6,008,518	12/28/99	TAKAHASHI			
<i>me</i>	AJ	6,221,721	04/24/01	TAKAHASHI			
<i>me</i>	AK	6,331,466	12/18/01	TAKAHASHI et al.			
<i>me</i>	AL	6,323,508	11/27/01	TAKAHASHI et al.			
<i>me</i>	AM	6,472,693	10/29/02	TAKAHASHI et al.			
<i>me</i>	AN	6,734,497	05/11/04	TAKAHASHI et al.			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
me	AO					
me	AP					
me	AQ					
me	AR					
me	AS					
me	AT					
me	AU					
me	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

me	AW	
me	AX	
me	AY	
me	AZ	

☐ Additional References sheet(s) attached

Examiner

Mark C. Chen

Date Considered

7/27/05

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